

**Search Notes**

Application/Control No.

10/752,010

Examiner

Anh Q. Tran

Applicant(s)/Patent under  
Reexamination

SEIKE, TOSHIMICHI

Art Unit

2819

**SEARCHED**

Class	Subclass	Date	Examiner
326	26-27, 82-83	2/2/2006	AT
327	108, 112	2/2/2006	AT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
east search-see printout		2/2/2006	AT

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east search-see printout	2/2/2006	AT